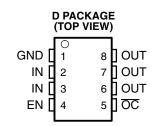
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- Qualified for Automotive Applications
- 33-mΩ (5-V Input) High-Side MOSFET Switch
- Short-Circuit and Thermal Protection
- Overcurrent Logic Output
- Operating Range . . . 2.7 V to 5.5 V
- Logic-Level Enable Input
- Typical Rise Time . . . 6.1 ms
- Undervoltage Lockout
- Maximum Standby Supply Current . . . 10 μA

- No Drain-Source Back-Gate Diode
- Available in 8-pin SOIC Package
- Ambient Temperature Range, –40°C to 85°C
- 2-kV Human-Body-Model, 200-V Machine-Model ESD Protection
- UL Listed File No. E169910



description

The TPS203x family of power distribution switches is intended for applications where heavy capacitive loads and short circuits are likely to be encountered. These devices are $50-m\Omega$ N-channel MOSFET high-side power switches. The switch is controlled by a logic enable compatible with 5-V logic and 3-V logic. Gate drive is provided by an internal charge pump designed to control the power-switch rise times and fall times to minimize current surges during switching. The charge pump requires no external components and allows operation from supplies as low as 2.7 V.

When the output load exceeds the current-limit threshold or a short is present, the TPS203x limits the output current to a safe level by switching into a constant-current mode, pulling the overcurrent (\overline{OC}) logic output low. When continuous heavy overloads and short circuits increase the power dissipation in the switch, causing the junction temperature to rise, a thermal protection circuit shuts off the switch to prevent damage. Recovery from a thermal shutdown is automatic once the device has cooled sufficiently. Internal circuitry ensures the switch remains off until valid input voltage is present.

The TPS203x devices differ only in short-circuit current threshold. The TPS2030 limits at 0.3-A load, the TPS2031 at 0.9-A load, the TPS2032 at 1.5-A load, the TPS2033 at 2.2-A load, and the TPS2034 at 3-A load (see Available Options). The TPS203x is available in an 8-pin small-outline integrated-circuit (SOIC) package and in an 8-pin dual in-line (DIP) package and operates over a junction temperature range of -40° C to 125°C.

			GENERAL S	ИТСН С	ATALOG	à			
33 mΩ, single	TPS201xA TPS202x TPS203x	0.2 A – 2 A 0.2 A – 2 A 0.2 A – 2 A	80 mΩ, dual	TPS2042 TPS2052 TPS2046 TPS2056	500 mA 500 mA 250 mA 250 mA	80 mΩ, tri	i ple ┌─		quad □
80 mΩ, single	TPS2014 TPS2015 TPS2041 TPS2051 TPS2045 TPS2055	600 mA 1 A 500 mA 500 mA 250 mA 250 mA	260 mΩ IN1OOUT IN2OUT 1.3 Ω	TPS2100/1 IN1 IN2 TPS2102/3 IN1 IN2	500 mA 10 mA /4/5 500 mA 100 mA	TPS2053 TPS2047	500 mA 500 mA 250 mA 250 mA	L TPS2044 TPS2054 TPS2058 TPS2058	0 500 mA 500 mA 250 mA 250 mA 250 mA



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	AVAILABLE OPTIONS [†]										
		RECOMMENDED	TYPICAL SHORT-CIRCUIT	PACKAGED DEVICES [‡]							
T _A	ENABLE	MAXIMUM CONTINUOUS LOAD CURRENT (A)	CURRENT LIMIT AT 25°C (A)	SMALL OUTLINE (D) [§]							
		0.2	0.3	TPS2030IDRQ1							
		0.6	0.9	TPS2031IDRQ1							
-40°C to 85°C	Active high	1	1.5	TPS2032IDRQ1							
		1.5	2.2	TPS2033IDRQ1							
		2	3	TPS2034IDRQ1							

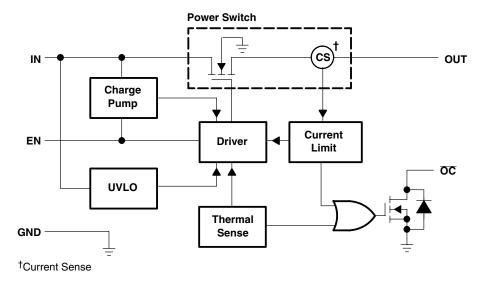
[†] For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at http://www.ti.com.

[‡] Package drawings, thermal data, and symbolization are available at http://www.ti.com/packaging.

§ The D package is available taped and reeled. Add an R suffix to device type (e.g., TPS2030IDRQ1)

[¶] Product Preview

TPS2030 functional block diagram



Terminal Functions

TEI	RMINAL		DECODIDEION					
NAME NO.		1/0	DESCRIPTION					
EN	4	I	Enable input. Logic high turns on power switch.					
GND	1	Ι	Ground					
IN	2, 3	Ι	Input voltage					
OC	5	0	Overcurrent. Logic output active low					
OUT	6, 7, 8	0	Power-switch output					



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detailed description

power switch

The power switch is an N-channel MOSFET with a maximum on-state resistance of 50 m Ω (V_{I(IN)} = 5 V). Configured as a high-side switch, the power switch prevents current flow from OUT to IN and IN to OUT when disabled.

charge pump

An internal charge pump supplies power to the driver circuit and provides the necessary voltage to pull the gate of the MOSFET above the source. The charge pump operates from input voltages as low as 2.7 V and requires very little supply current.

driver

The driver controls the gate voltage of the power switch. To limit large current surges and reduce the associated electromagnetic interference (EMI) produced, the driver incorporates circuitry that controls the rise times and fall times of the output voltage. The rise and fall times are typically in the 2-ms to 9-ms range.

enable (EN)

The logic enable disables the power switch, the bias for the charge pump, driver, and other circuitry to reduce the supply current to less than 10 μ A when a logic low is present on EN . A logic high input on EN restores bias to the drive and control circuits and turns the power on. The enable input is compatible with both TTL and CMOS logic levels.

overcurrent (OC)

The \overline{OC} open drain output is asserted (active low) when an overcurrent or overtemperature condition is encountered. The output remains asserted until the overcurrent or overtemperature condition is removed.

current sense

A sense FET monitors the current supplied to the load. The sense FET measures current more efficiently than conventional resistance methods. When an overload or short circuit is encountered, the current-sense circuitry sends a control signal to the driver. The driver, in turn, reduces the gate voltage and drives the power FET into its saturation region, which switches the output into a constant current mode and holds the current constant while varying the voltage on the load.

thermal sense

An internal thermal-sense circuit shuts off the power switch when the junction temperature rises to approximately 140°C. Hysteresis is built into the thermal sense circuit. After the device has cooled approximately 20°C, the switch turns back on. The switch continues to cycle off and on until the fault is removed.

undervoltage lockout

A voltage sense circuit monitors the input voltage. When the input voltage is below approximately 2 V, a control signal turns off the power switch.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Input voltage range, V _{I(IN)} (see Note 1)	
Output voltage range, V _{O(OUT)} (see Note 1)	$\dots \dots \dots \dots -0.3 \text{ V to V}_{I(IN)} + 0.3 \text{ V}$
Input voltage range,V _{I(EN)}	–0.3 V to 6 V
Continuous output current, I _{O(OUT)}	internally limited
Continuous total power dissipation	
Operating virtual junction temperature range, T _J	–40°C to 125°C
Storage temperature range, T _{stg}	
Lead temperature soldering 1,6 mm (1/16 inch) from case for 10 seconds	
Electrostatic discharge (ESD) protection: Human body model	2 kV
Machine model	200V
Charged device model (CDM)	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltages are with respect to GND.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C	DERATING FACTOR	T _A = 70°C	T _A = 85°C
	POWER RATING	ABOVE T _A = 25°C	POWER RATING	POWER RATING
D	725 mW	5.8 mW/°C	464 mW	377 mW

recommended operating conditions

		MIN	MAX	UNIT
lanut valta na	V _{I(IN)}	2.7	5.5	V
Input voltage	V _{I(EN)}	0	5.5	V
	TPS2030	0	0.2	
	TPS2031	0	0.6	
Continuous output current, I _O	TPS2032	0	1	А
	TPS2033	0	1.5	
	V _{I(IN)} 2.7 5.5 V _{I(EN)} 0 5.5 TPS2030 0 0.2 TPS2031 0 0.6 TPS2032 0 1 TPS2033 0 1.5 TPS2034 0 2			
Operating virtual junction tempera	iture, T _J	-40	125	°C



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electrical characteristics over recommended operating junction temperature range, $V_{I(IN)}$ = 5.5 V, I_0 = rated current, EN = 5 V, T_J = -40°C to 125°C (unless otherwise noted)

power switch

	PARAMETER	т	EST CONDITIO	NS†	MIN	TYP	MAX	UNIT
			$T_J = 25^{\circ}C$,	I _O = 1.8 A [‡]		33	36	
		V _{I(IN)} = 5 V,				38	46	
$r_{DS(on)} = Static drain-source on-state resistance = $	T _J = 125°C,	I _O = 1.8 A [‡]		44	50			
	37	41						
		V _{I(IN)} = 3.3 V,	$T_J = 85^{\circ}C$,	I _O = 1.8 A [‡]		43	52	
_	Statia drain acuras an atata registance		T _J = 125°C,	I _O = 1.8 A [‡]		51	61	
rDS(on)	Static drain-source on-state resistance		$T_J = 25^{\circ}C$,	I _O = 0.18 A		30	34	mΩ
		V _{I(IN)} = 5 V,	$T_J = 85^{\circ}C$,	I _O = 0.18 A		35	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	
			T _J = 125°C,	I _O = 0.18 A		39	55	
			$T_J = 25^{\circ}C$,	I _O = 0.18 A		33	37	
		V _{I(IN)} = 3.3 V,	$T_J = 85^{\circ}C$,	I _O = 0.18 A		39	55	
			T _J = 125°C,	I _O = 0.18 A		44	66	
		$\begin{array}{l} V_{I(IN)}=5.5 \ \text{V}, \\ C_L=1 \ \mu\text{F}, \end{array}$	$T_J = 25^{\circ}C,$ $R_L = 10 \Omega$			6.1		
t _r Rise	Rise time, output					8.6		ms
		$\begin{array}{l} V_{I(IN)}=5.5 \ \text{V},\\ C_L=1 \ \mu\text{F}, \end{array}$	$T_J = 25^{\circ}C,$ $R_L = 10 \Omega$			3.4		m 0
łf	ran ume, output	$V_{I(IN)} = 2.7 V,$ $C_L = 1 \mu F,$				3		ms

[†] Pulse-testing techniques maintain junction temperature close to ambient temperature; thermal effects must be taken into account separately. [‡] Not production tested

enable input (EN)

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
V_{IH}	High-level input voltage	$2.7~V \leq V_{I(IN)} \leq 5.5~V$	2			V
v		$4.5~V \leq V_{I(IN)} \leq 5.5~V$			0.8	v
V _{IL}	Low-level input voltage	$2.7~V \leq V_{I(IN)} \leq 4.5~V$			0.5	v
l _l	Input current	$EN = 0 V \text{ or } EN = V_{I(IN)}$	-0.5		0.5	μA
t _{on}	Turnon time	C_L = 100 μ F, R_L = 10 Ω			20	me
t _{off}	Turnoff time	C_L = 100 μ F, R_L = 10 Ω			40	ms

current limit

	PARAMETER	TEST CONDITIONS [†]		MIN	ТҮР	MAX	UNIT
			TPS2030	0.22	0.3	0.4	
		$T_1 = 25^{\circ}C, V_1 = 5.5 V,$	TPS2031	0.66	0.9	1.1	ļ
I _{OS}	Short-circuit output current	o	TPS2032	1.1	1.5	1.8	А
			TPS2033	1.65	2.2	2.7	
			TPS2034	2.2	3	3.8	

[†] Pulse-testing techniques maintain junction temperature close to ambient temperature; thermal effects must be taken into account separately.



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electrical characteristics over recommended operating junction temperature range, $V_{I(IN)}$ = 5.5 V, I_O = rated current, EN = 5 V, T_A = -40°C to 125°C (unless otherwise noted) (continued)

supply current

PARAMETER	TEST	TEST CONDITIONS		MIN	TYP	MAX	UNIT
	No Lood on OUT		$T_J = 25^{\circ}C$		0.3	1	
Supply current, low-level output	No Load on OUT	EN = 0	$-40^\circ C \leq T_J \leq 125^\circ C$			10	μA
Querely average black level average			$T_J = 25^{\circ}C$		58	75	
Supply current, high-level output	No Load on OUT	$EN = V_{I(IN)}$	$-40^\circ C \leq T_J \leq 125^\circ C$		75	100	μA
Leakage current	OUT connected to ground	EN = 0	$-40^\circ C \leq T_J \leq 125^\circ C$		10		μA

undervoltage lockout

PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
Low-level input voltage		2		2.5	V
Hysteresis	$T_J = 25^{\circ}C$		100		mV

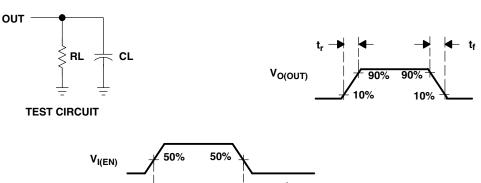
overcurrent (OC)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output low voltage	$I_{O} = 10 \text{ mA}, V_{OL(\overline{OC})}$			0.5	V
Off-state current [†]	$V_{O} = 5 V$, $V_{O} = 3.3 V$			1	μA

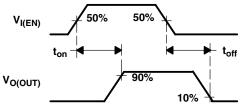
[†] Specified by design, not production tested.



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PARAMETER MEASUREMENT INFORMATION



VOLTAGE WAVEFORMS

Figure 1. Test Circuit and Voltage Waveforms

Table of Timing Diagrams

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Turnon Delay and Rise TIme	2
Turnoff Delay and Fall Time	3
Turnon Delay and Rise TIme with 1- μ F Load	4
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Device Enabled Into Short	6
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7.9- Ω Load Connected to an Enabled TPS2030 Device	13
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3.7- Ω Load Connected to an Enabled TPS2031 Device	15
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2.6- Ω Load Connected to an Enabled TPS2032 Device	17
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1.2- Ω Load Connected to an Enabled TPS2033 Device	19
0.9- Ω Load Connected to an Enabled TPS2033 Device	20
0.9- Ω Load Connected to an Enabled TPS2034 Device	21
$0.5-\Omega$ Load Connected to an Enabled TPS2034 Device	22



PARAMETER MEASUREMENT INFORMATION

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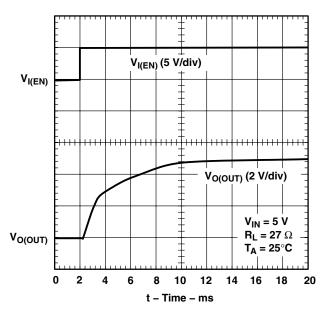
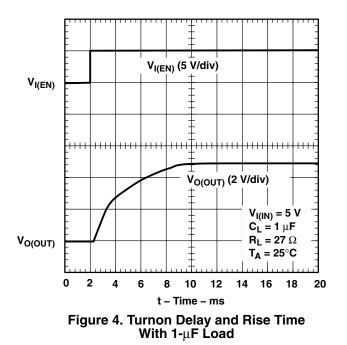


Figure 2. Turnon Delay and Rise Time



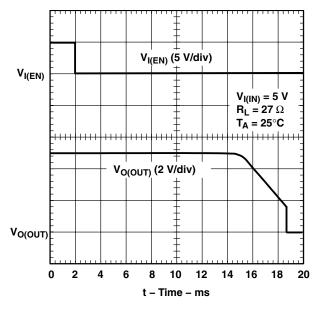


Figure 3. Turnoff Delay and Fall Time

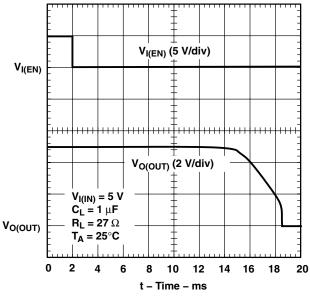
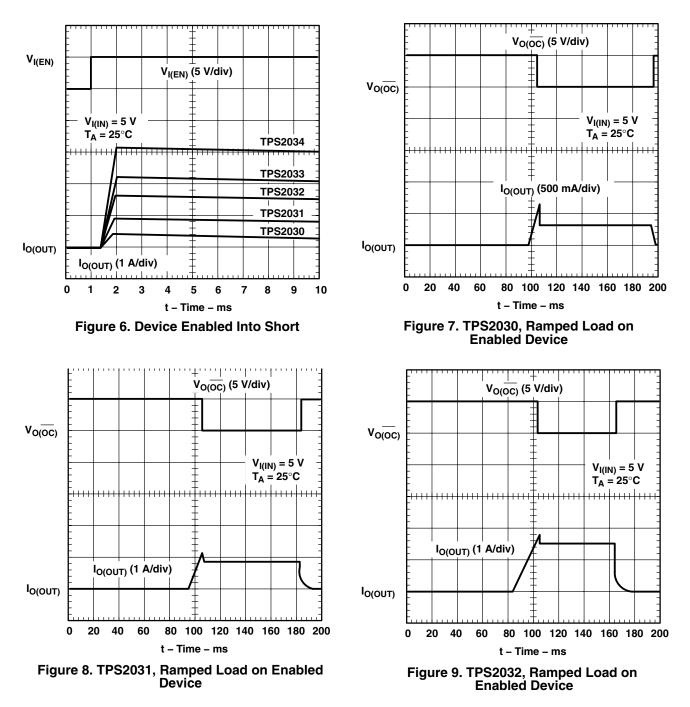


Figure 5. Turnoff Delay and Fall Time With 1- μ F Load



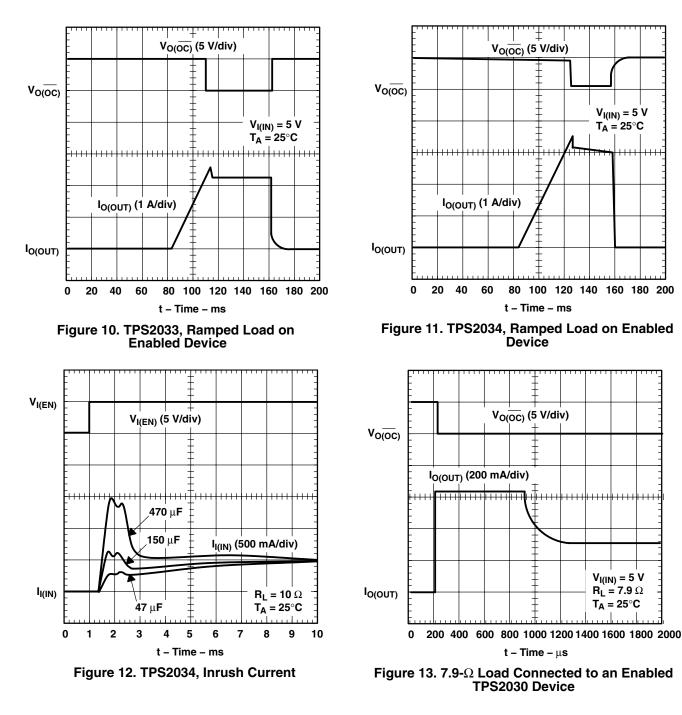
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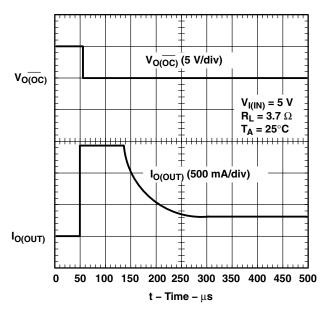
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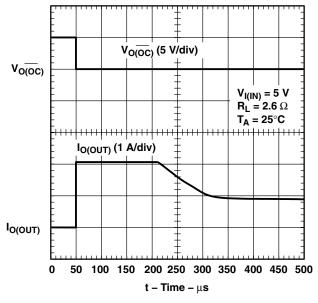


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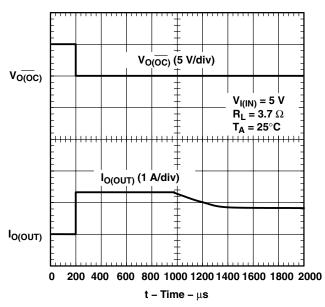
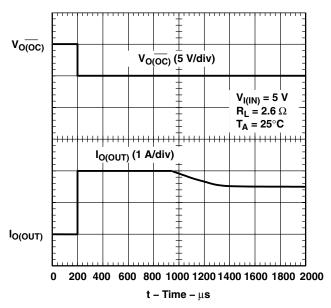


Figure 15. 3.7- Ω Load Connected to an Enabled TPS2031 Device







PARAMETER MEASUREMENT INFORMATION

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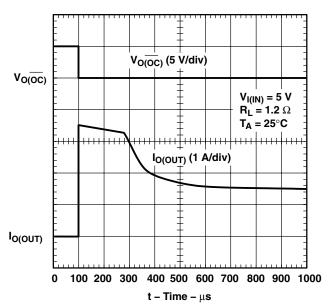
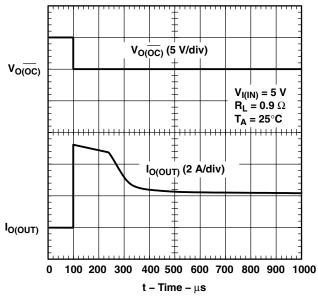


Figure 18. 1.2- Ω Load Connected to an Enabled TPS2032 Device





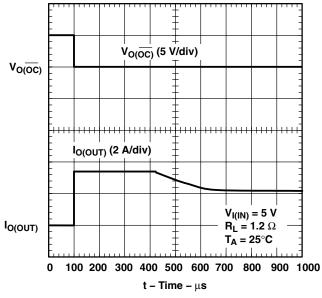
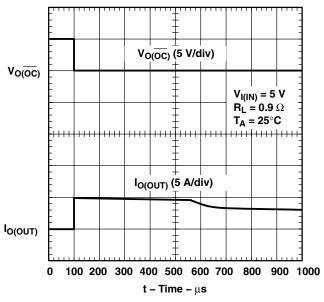


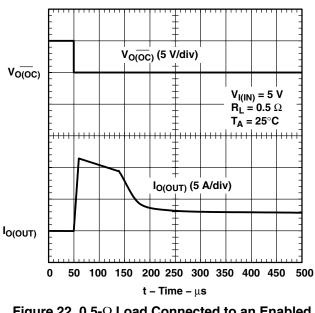
Figure 19. 1.2- Ω Load Connected to an Enabled TPS2033 Device







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PARAMETER MEASUREMENT INFORMATION



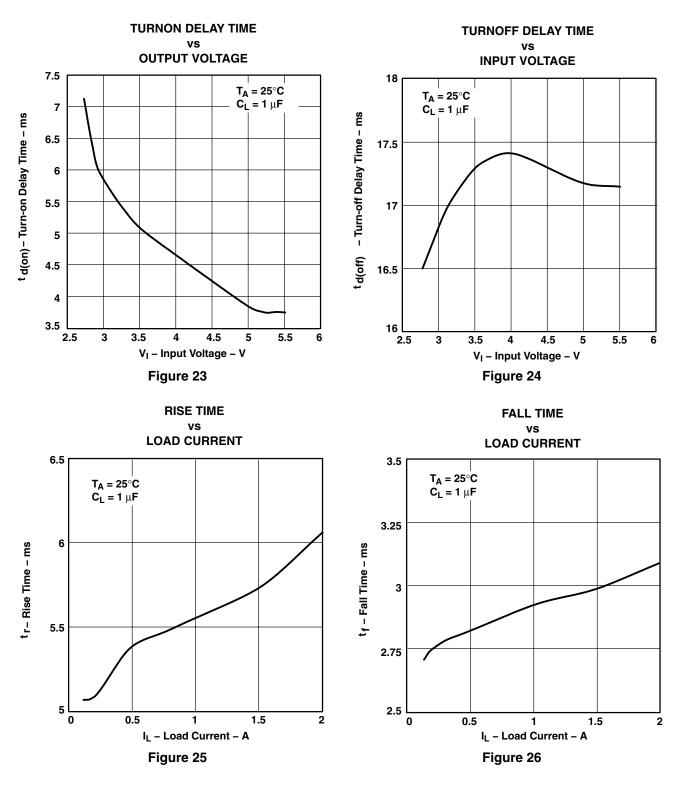
TYPICAL CHARACTERISTICS

Table of Graphs

			FIGURE
t _{d(on)}	Turnon delay time	vs Output voltage	23
t _{d(off)}	Turnoff delay time	vs Input voltage	24
t _r	Rise time	vs Load current	25
t _f	Fall time	vs Load current	26
	Supply current (enabled)	vs Junction temperature	27
	Supply current (disabled)	vs Junction temperature	28
	Supply current (enabled)	vs Input voltage	29
	Supply current (disabled)	vs Input voltage	30
I _{OS}		vs Input voltage	31
	Short-circuit current limit	vs Junction temperature	32
r _{DS(on)}		vs Input voltage	33
	o	vs Junction temperature	34
	Static drain-source on-state resistance	vs Input voltage	35
		vs Junction temperature	36
VI	Input voltage	Undervoltage lockout	37



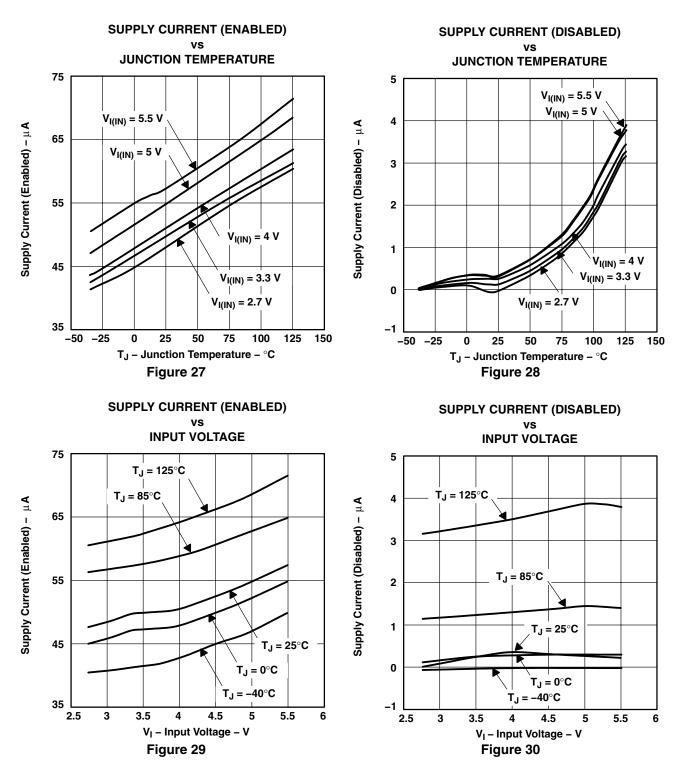
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TYPICAL CHARACTERISTICS



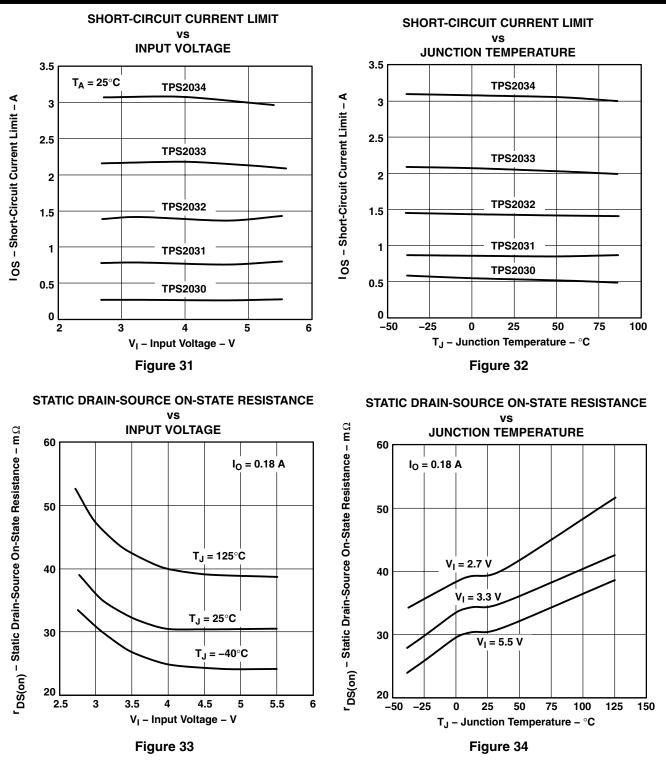
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TYPICAL CHARACTERISTICS

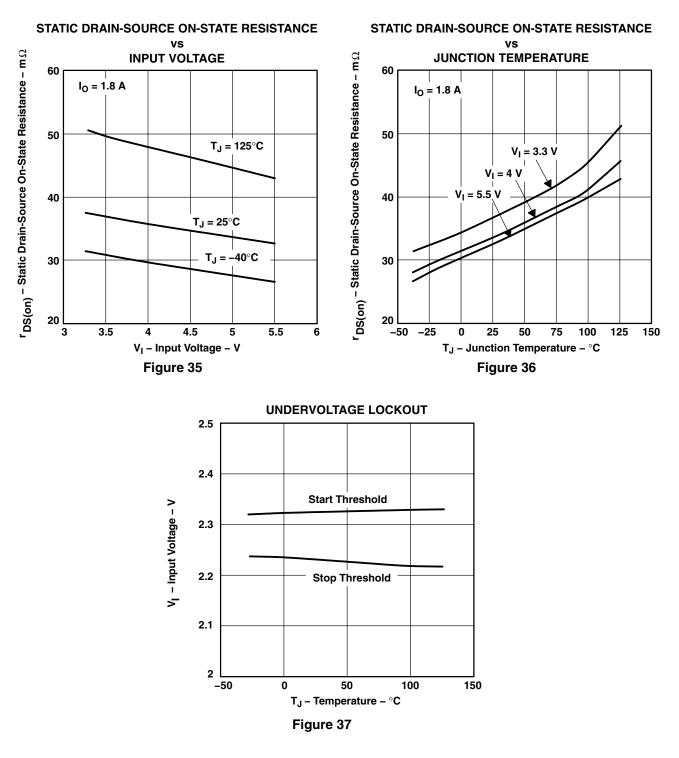


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TYPICAL CHARACTERISTICS



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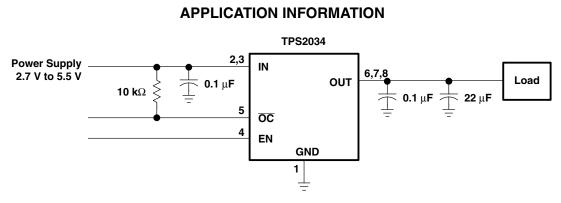


Figure 38. Typical Application

power supply considerations

A 0.01- μ F to 0.1- μ F ceramic bypass capacitor between IN and GND, close to the device, is recommended. Placing a high-value electrolytic capacitor on the output and input pins is recommended when the output load is heavy. This precaution reduces power supply transients that may cause ringing on the input. Additionally, bypassing the output with a 0.01- μ F to 0.1- μ F ceramic capacitor improves the immunity of the device to short-circuit transients.

overcurrent

A sense FET checks for overcurrent conditions. Unlike current-sense resistors, sense FETs do not increase the series resistance of the current path. When an overcurrent condition is detected, the device maintains a constant output current and reduces the output voltage accordingly. Complete shutdown occurs only if the fault is present long enough to activate thermal limiting.

Three possible overload conditions can occur. In the first condition, the output has been shorted before the device is enabled or before $V_{I(IN)}$ has been applied (see Figure 6). The TPS203x senses the short and immediately switches into a constant-current output.

In the second condition, the excessive load occurs while the device is enabled. At the instant the excessive load occurs, high currents may flow for a short time before the current-limit circuit can react (see Figure 13 through Figure 22). After the current-limit circuit has tripped (reached the overcurrent trip threshold) the device switches into constant-current mode.

In the third condition, the load has been gradually increased beyond the recommended operating current. The current is permitted to rise until the current-limit threshold is reached or until the thermal limit of the device is exceeded (see Figure 7 through Figure 11). The TPS203x is capable of delivering current up to the current-limit threshold without damaging the device. Once the threshold has been reached, the device switches into its constant-current mode.

OC response

The \overline{OC} open-drain output is asserted (active low) when an overcurrent or overtemperature condition is encountered. The output remains asserted until the overcurrent or overtemperature condition is removed. Connecting a heavy capacitive load to an enabled device can cause momentary false overcurrent reporting from the inrush current flowing through the device, charging the downstream capacitor. An RC filter can be connected to the \overline{OC} pin to reduce false overcurrent reporting. Using low-ESR electrolytic capacitors on the output lowers the inrush current flow through the device during hot-plug events by providing a low impedance energy source, thereby reducing erroneous overcurrent reporting.



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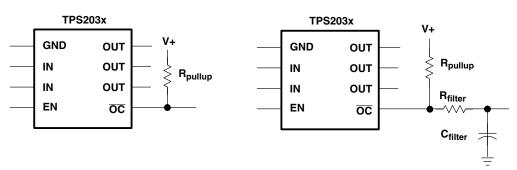


Figure 39. Typical Circuit for OC Pin and RC Filter for Damping Inrush OC Responses

power dissipation and junction temperature

The low on-resistance on the n-channel MOSFET allows small surface-mount packages, such as SOIC, to pass large currents. The thermal resistances of these packages are high compared to those of power packages; it is good design practice to check power dissipation and junction temperature. The first step is to find $r_{DS(on)}$ at the input voltage and operating temperature. As an initial estimate, use the highest operating ambient temperature of interest and read $r_{DS(on)}$ from Figure 33 through Figure 36. Next, calculate the power dissipation using:

$$P_D = r_{DS(on)} \times l^2$$

Finally, calculate the junction temperature:

$$T_J = P_D \times R_{\theta JA} + T_A$$

Where:

 T_A = Ambient Temperature °C $R_{\theta JA}$ = Thermal resistance SOIC = 172°C/W, PDIP = 106°C/W

Compare the calculated junction temperature with the initial estimate. If they do not agree within a few degrees, repeat the calculation, using the calculated value as the new estimate. Two or three iterations are generally sufficient to get an acceptable answer.

thermal protection

Thermal protection prevents damage to the IC when heavy-overload or short-circuit faults are present for extended periods of time. The faults force the TPS203x into constant current mode, which causes the voltage across the high-side switch to increase; under short-circuit conditions, the voltage across the switch is equal to the input voltage. The increased dissipation causes the junction temperature to rise to high levels. The protection circuit senses the junction temperature of the switch and shuts it off. Hysteresis is built into the thermal sense circuit, and after the device has cooled approximately 20 degrees, the switch turns back on. The switch continues to cycle in this manner until the load fault or input power is removed.

undervoltage lockout (UVLO)

An undervoltage lockout ensures that the power switch is in the off state at powerup. Whenever the input voltage falls below approximately 2 V, the power switch will be quickly turned off. This facilitates the design of hot-insertion systems where it is not possible to turn off the power switch before input power is removed. The UVLO also keeps the switch from being turned on until the power supply has reached at least 2 V, even if the switch is enabled. Upon reinsertion, the power switch will be turned on, with a controlled rise time to reduce EMI and voltage overshoots.



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APPLICATION INFORMATION

generic hot-plug applications (see Figure 40)

In many applications it may be necessary to remove modules or pc boards while the main unit is still operating. These are considered hot-plug applications. Such implementations require the control of current surges seen by the main power supply and the card being inserted. The most effective way to control these surges is to limit and slowly ramp the current and voltage being applied to the card, similar to the way in which a power supply normally turns on. Because of the controlled rise times and fall times of the TPS203x series, these devices can be used to provide a softer start-up to devices being hot-plugged into a powered system. The UVLO feature of the TPS203x also ensures the switch will be off after the card has been removed, and the switch will be off during the next insertion. The UVLO feature assures a soft start with a controlled rise time for every insertion of the card or module.

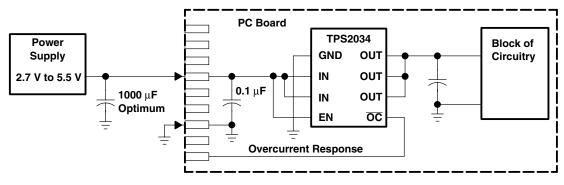


Figure 40. Typical Hot-Plug Implementation

By placing the TPS203x between the V_{CC} input and the rest of the circuitry, the input power reaches this device first after insertion. The typical rise time of the switch is approximately 9 ms, providing a slow voltage ramp at the output of the device. This implementation controls system surge currents and provides a hot-plugging mechanism for any device.





24-Jan-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing			(2)		(3)		(4)	
TPS2030IDRG4Q1	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	2030Q1	Samples
TPS2030IDRQ1	OBSOLETE	SOIC	D	8		TBD	Call TI	Call TI	-40 to 85	2030Q1	

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ Only one of markings shown within the brackets will appear on the physical device.

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OTHER QUALIFIED VERSIONS OF TPS2030-Q1 :

Catalog: TPS2030



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PACKAGE OPTION ADDENDUM

24-Jan-2013

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AA.



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